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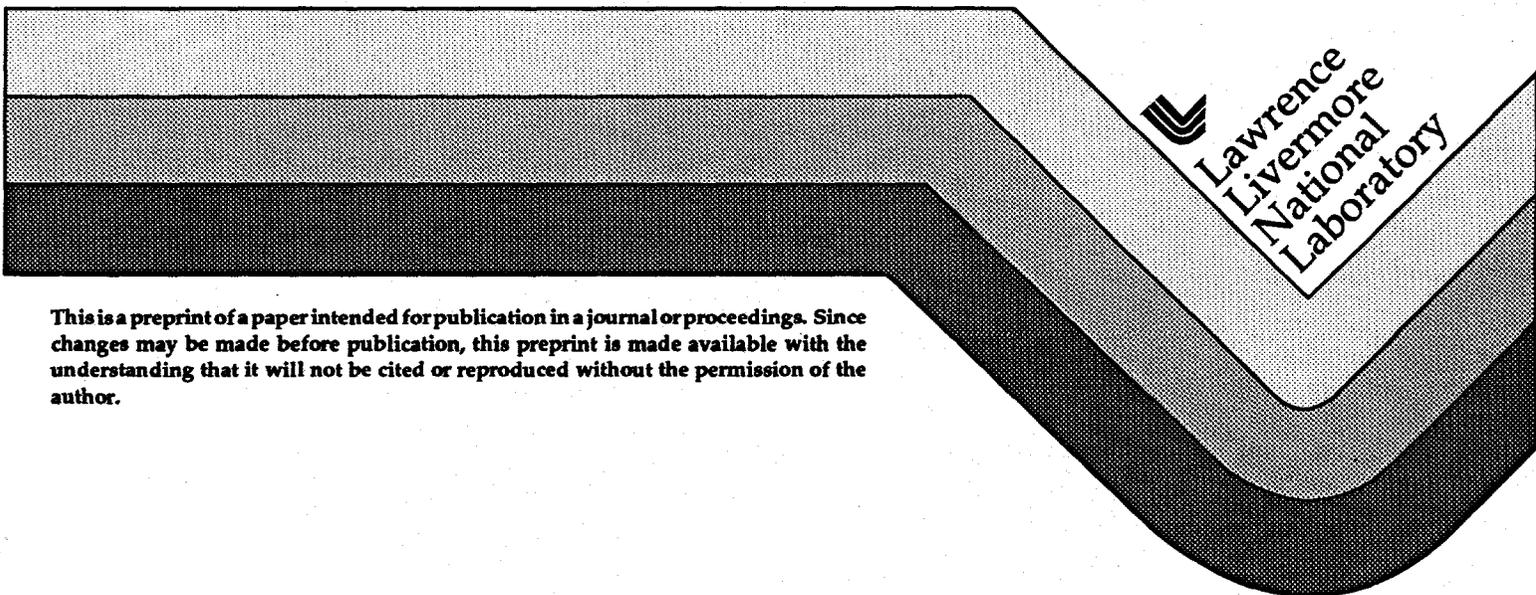
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Characterization and Modeling of Soft X-ray Lasers

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Abstract

This paper describes our theoretical, numerical, and experimental development of short-pulse-duration, high brightness, and enhanced coherence x-ray lasers (XRLs) as sources suitable for applications as imaging diagnostics for laser plasmas.

1. Introduction

With its short wavelength (40–400 Å), short controllable pulse duration, high peak brightness, and sufficient spatial and temporal coherence, soft XRLs have been considered for applications in the fields of microscopy, holography, material science, and plasma physics.¹ Utilizing multilayer mirrors and beamsplitters and a collisionally pumped neon-like yttrium XRL operating at 155 Å as the probe source, we have recently demonstrated a soft XRL interferometer in a skewed Mach-Zehnder configuration.² With this soft XRL interferometer, we have measured two-dimensional electron density profiles of fast evolving, high-density laser-produced plasmas that exceed 10^{21} cm⁻³ for a large plasma that is millimeters in extent.

For plasma imaging applications we typically use a 3-cm-long yttrium slab XRL,³ driven by a 600-ps gaussian optical laser pulse, with an output energy of ~ 8 mJ, ~300-ps full-width at half-maximum (FWHM) pulse duration, ~ 100 μm diameter source size, 10-mrad divergence, and bandwidth ($\lambda/\Delta\lambda$) of 10^4 , which corresponds to a brightness of ~ 10^{17} W/sr-Å-cm². This brightness is equivalent to a 6-GeV blackbody, which, when used in conjunction with multilayer optics designed for the XRL wavelength, can overwhelm the self-emission of the target plasma. This paper describes our recent experimental and theoretical characterization and modeling of XRLs at the Lawrence Livermore National Laboratory (LLNL). These studies point toward methods to further improve the XRL performance for future plasma imaging applications.

2. Properties of Soft X-ray Laser

The coupling of the optical laser with the XRL target produced rapid plasma expansion with strong electron density gradient which resulted in large refraction and large beam divergence. By using either a prepulse or a multiple, picket-fence-shaped driving optical laser pulse, the main driving laser pulse is now coupled to a pre-formed plasma and lasing occurs at a region with flatter density profiles. With the new pulse shapes, we observed strong 3p - 3s J = 0-1 XRL output which dominates the XRL spectrum. Strong J = 0-1 XRLs have now been observed over a large number of elements, ranging as low as chlorine at Z=17 to selenium at Z=34.^{4,5} This reduced refraction is a likely explanation for the emergence of the J = 0-1 line which lases at higher density regime. Another way to compensate for refraction is by bending the XRL target at an appropriate curvature. By proper guiding of the XRL photons, Kodama⁶ has observed a narrowing of the beam divergence to ~ 1 mrad, which represents a significant increase in the output brightness.

We are developing techniques to shorten the time duration of the XRL while maintaining high brightness in order to optimize their usefulness as a plasma diagnostics. The drive pulse duration is directly related to the XRL duration. Using multiple pulse techniques and combined with traveling wave geometry,⁷ we have shortened the x-ray lasing duration down to <50 ps. However, the intensity of the XRL is about two orders of magnitude weaker as compared to long-

duration pumping. We are looking at using curved targets and pulse shaping techniques⁸ to more efficiently pump the neon-like XRL system and to increase the XRL output.

We are also developing an XRL cavity to boost the output of XRLs while maintaining a short-pulse duration. Our approach on cavity development⁹ is to place the injection mirror far away from the XRL to minimize multilayer damage and to use the multiple-pulse configuration on Nova, timed such that the XRL photons produced in earlier pulses will be reinjected and propagate through the gain medium created by latter pulses. We verify the successful locking by measuring the near-field emission profiles of the XRL plasma, from which we can also estimate the spatial gain and n_e profiles, and how they affect the dynamics of XRL plasmas.

The spatial and temporal coherence of the XRL become an important consideration in the design of a Mach-Zehnder interferometer. The observed fringe visibility is sensitive to both the temporal and spatial overlap of the recombined beams which allows us to characterize the spatial and temporal coherence of the XRL.¹⁰ By changing the optical path length between the two arms of the interferometer and perform a gaussian fit to the measured fringe visibility, we obtained a $1/e$ width of 100 μm for the yttrium XRL line at 155 \AA , which is approximately equivalent to a FWHM linewidth of 13 m \AA . This is consistent with previous direct measurement of the linewidth using a high-precision spectrometer.¹¹ We also measured an effective source dimension of 320 μm by quantifying the change of the fringe visibility over a distorted region of the beamsplitter.

Beyond the 2-D interferometer, a diffraction-limited XRL can yield flash 3-D interferometric image of an ICF capsule. We are working on improving the spatial coherence of current XRLs by developing small-source-size oscillators and multiple-component XRL architectures. By controlling the shape of XRLs during plasma expansion and reducing the effective XRL source size using the concept of adaptive spatial filtering, we can obtain a diffraction-limited XRL with a high effective power. With the reduced source size, these XRLs can serve as driving oscillators in a multiple-component XRL architecture. Part of our effort are devoted to study the hydrodynamics and laser physics of such shaped XRLs and to study the coupling of multiple components in such laser architectures.¹²

Acknowledgments

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